

Description

The BSC025N03MSG uses advanced trench technology to provice excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a

Battery protection or in other Switching application.

General Features

V_{DS} = 30V I_D =150A

 $R_{DS(ON)}$ < 2.4m Ω V_{GS}=10V

Application

Battery protection

Load switch

Uninterruptible power supply

Package Marking and Ordering Information

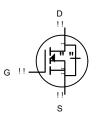
Package marking and Ordering information						
Product ID	Pack	Brand	Qty(PCS)			
BSC025N03MSG	DFN5X6-8L(TDSON-8)	HXY MOSFET	5000			

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
Vds	Drain-Source Voltage	Source Voltage 30	
VGS	Gate-Source Voltage	±20	V
I₀@Tc=25°C	Continuous Drain Current, V _{GS} @ 10V ¹	150	А
I⊳@Tc=100°C	Continuous Drain Current, V _{GS} @ 10V ¹	80	A
Ідм	Pulsed Drain Current ²	160	А
EAS	Single Pulse Avalanche Energy ³	180	mJ
las	Avalanche Current	60	A
P _D @T _C =25°C	Total Power Dissipation ⁴	187	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Reja	Thermal Resistance Junction-Ambient ¹	62	°C/W
Rejc	Thermal Resistance Junction-Case ¹	1.1	°C/W

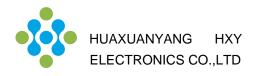


DFN5X6-8L (TDSON-8)



N-Channel MOSFET

N-Channel Enhancement Mode MOSFET



Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V	
$\triangle BV_{DSS} / \triangle T_J$	BV _{DSS} Temperature Coefficient	Reference to 25°C,I _D =1mA		0.014		V/°C	
D	Statia Drain Source On Desistance ²	V _{GS} =10V , I _D =30A	V _{GS} =10V , I _D =30A		2.4		
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =15A		2.5	3.2	mΩ	
V _{GS(th)}	Gate Threshold Voltage		1.2		2.5	V	
$ riangle V_{GS(th)}$	V _{GS} =V _{DS} , I _D =250uA			-4		mV/°C	
1	Drain Source Lookage Current	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	uA	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55°C			5		
lgss	I _{GSS} Gate-Source Leakage Current V _{GS} =±20V, V _D				±100	nA	
gfs	Forward Transconductance	V _{DS} =5V , I _D =30A		50		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7		Ω	
Qg	Total Gate Charge (4.5V)			56.9			
Qgs	Gate-Source Charge	V _{DS} =15V , V _{GS} =10V , I _D =15A		13.8		nC	
Q_{gd}	Gate-Drain Charge			23.5			
T _{d(on)}	Turn-On Delay Time			20.1		ns	
Tr	Rise Time	V _{DD} =15V , V _{GS} =10V , R _G =3.3Ω, I _D =1A		6.3			
$T_{d(off)}$	Turn-Off Delay Time			124.6			
T _f	Fall Time			15.8			
Ciss	Input Capacitance			4345			
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		340		pF	
Crss	Reverse Transfer Capacitance			225			
ls	Continuous Source Current ^{1,6}	V _G =V _D =0V , Force Current			150	А	
Vsd	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1.2	V	

Note:

1. The data tested by surface mounted on a 1 inch $^2\,\text{FR-4}$ board with 2OZ copper.

2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS} =60A

4. The power dissipation is limited by 150°C junction temperature

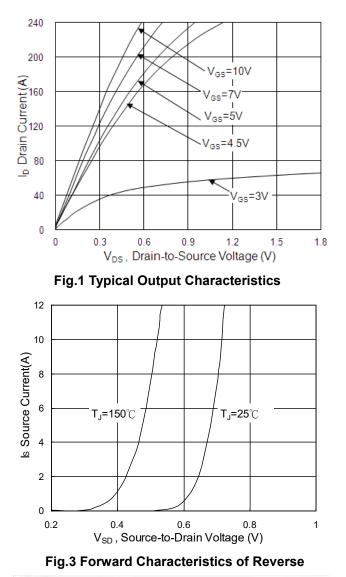
5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

6.Package limitation current is 85A.



BSC025N03MSG N-Channel Enhancement Mode MOSFET

Typical Characteristics



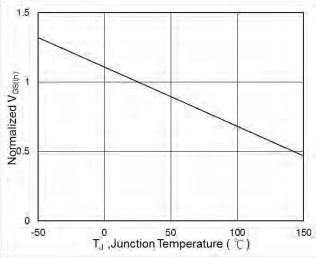


Fig.5 Normalized $V_{GS(th)}$ v.s T_J

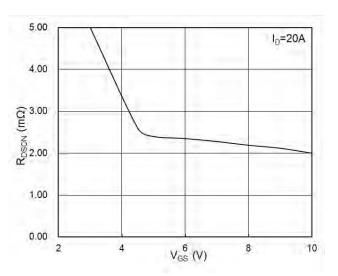


Fig.2 On-Resistance v.s Gate-Source

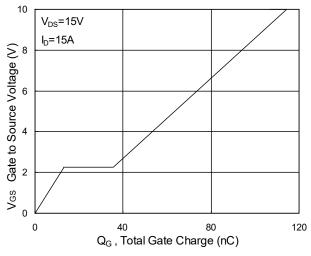


Fig.4 Gate-Charge Characteristics

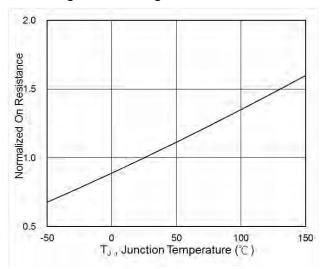


Fig.6 Normalized R_{DSON} v.s T_J



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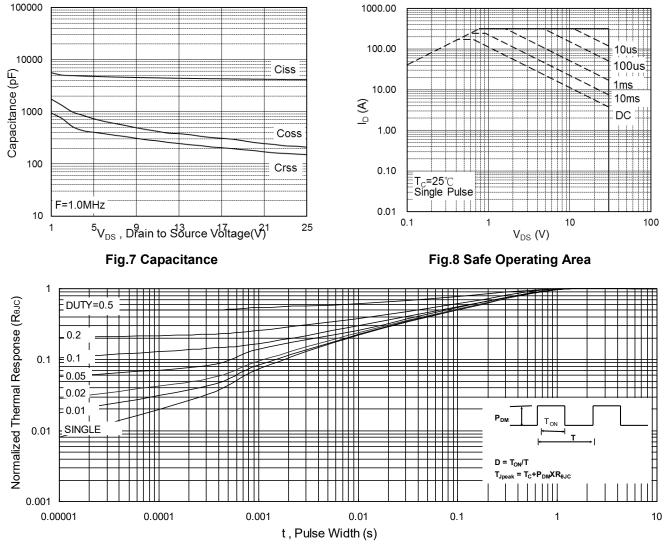


Fig.9 Normalized Maximum Transient Thermal Impedance

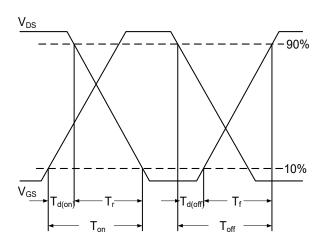


Fig.10 Switching Time Waveform

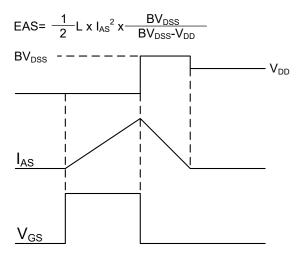
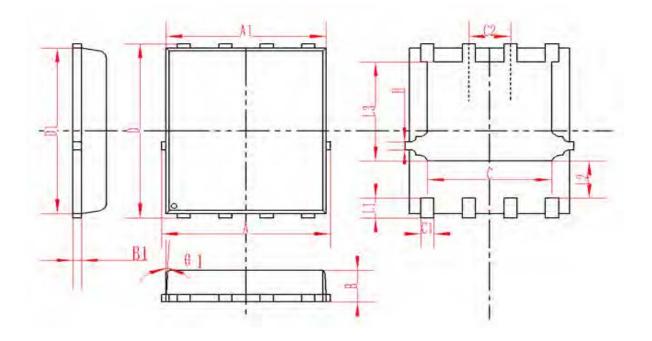


Fig.11 Unclamped Inductive Switching Waveform



DFN5X6-8L(TDSON-8) Package Information



SYMBOL	MM		INCH			
STIVIDOL	MIN	NOM	MAX	MIN	NOM	MAX
А	4.95	5	5.05	0.195	0.197	0.199
A1	4.82	4.9	4.98	0.190	0.193	0.196
D	5.98	6	6.02	0.235	0.236	0.237
D1	5.67	5.75	5.83	0.223	0.226	0.230
В	0.9	0.95	1	0.035	0.037	0.039
B1	0.254REF		0.010REF			
С	3.95	4	4.05	0.156	0.157	0.159
C1	0.35	0.4	0.45	0.014	0.016	0.018
C2	1.27TYP		0.5TYP			
θ1	8°	10°	12°	8°	10°	12°
L1	0.63	0.64	0.65	0.025	0.025	0.026
L2	1.2	1.3	1.4	0.047	0.051	0.055
L3	3.415	3.42	3.425	0.134	0.135	0.135
Н	0.24	0.25	0.26	0.009	0.010	0.010



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